

Search Notes

Application/Control No.

10/668,665

Examiner

Leigh C. Maier

Applicant(s)/Patent under
Reexamination

YVIN ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner
514	54	10/14/2005	LCM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
-STN text search (transcript attached)	10/4/2005	LCM
-EAST (transcript attached)	10/14/2005	LCM